U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT		Docket Number 10191/3283		
Application Number To Be Assigned	Filing Date Herewith	Examiner To Be Assigned	Art Unit To Be Assigned	
METHOD FOR PRODUCING INTEGRATED MICROSYSTEMS		Applicant(s) Wilhelm FREY et al.		

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

- 1. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorneys for Applicant(s) hereby bring the following reference(s) to the attention of the Examiner. The reference(s) are listed on the attached modified PTO Form No. 1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.
- 2. A copy of each patent, publication or other information listed on the modified PTO form 1449 is enclosed, except as otherwise indicated on the modified PTO form 1449.

Dated

By:

Richard L. Mayer (Reg. No. 22,49

KENYON & KENYON

One Broadway

New York, N.Y. 10004

(212) 425-7200 (telephone)

(212) 425-5288 (facsimile)

CUSTOMER NO. 26646

© Kenyon & Kenyon 1996

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449	ATTY. DOCKET NO. 10191/3283 APPLICANT(s) Wilhelm FREY et al.				
	FILING DATE Herewith	GROUP Not yet assigned			

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
	6,210,988	April 3, 2001	Howe et al.			

FOREIGN PATENT DOCUMENTS

EVANDIED	DOCUMENT					TRANSLATION	
EXAMINER INITIAL	NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	YES	NO
	38 74 411*	October 15, 1992	Fed. Rep. of Germany			Abş.	
	0 292 057**	November 23, 1988	Europe			Abs.	

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
	Franke et al., "Post-CMOS Modular Integration of Poly-SiGe Microstructures Using Poly-Ge Sacraficial Layers", Solid-State Sensor and Actuator Workshop, Hilton Head, SC, June 2000, pp. 18-21

EXAMINER	DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

^{*}Described in Specification

** Corresponds to German Patent No. 38 74 411.